

# High Voltage, Latch-Up Proof, 4-Channel Multiplexer

# ADG5204

#### **FEATURES**

Latch-up proof 3 pF off source capacitance 26 pF off drain capacitance -0.6 pC charge injection Low leakage: 0.4 nA maximum at 85°C ±9 V to ±22 V dual-supply operation 9 V to 40 V single-supply operation 48 V supply maximum ratings Fully specified at ±15 V, ±20 V, +12 V, and +36 V V<sub>SS</sub> to V<sub>DD</sub> analog signal range

#### **APPLICATIONS**

Automatic test equipment Data acquisition Instrumentation Avionics Audio and video switching Communication systems

#### **GENERAL DESCRIPTION**

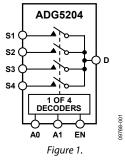
The ADG5204 is a complementary metal oxide semiconductor (CMOS) analog multiplexer, comprising four single channels.

The ultralow capacitance and charge injection of these switches make them ideal solutions for data acquisition and sample-andhold applications, where low glitch and fast settling are required. Fast switching speed together with high signal bandwidth make the ADG5204 suitable for video signal switching.

The ADG5204 is designed on a trench process, which guards against latch-up. A dielectric trench separates the P and N channel transistors, thereby preventing latch-up even under severe overvoltage conditions.

The ADG5204 switches one of four inputs to a common output, D, as determined by the 3-bit binary address lines, A0, A1, and EN. Logic 0 on the EN pin disables the device. Each switch conducts equally well in both directions when on, and each switch has an input signal range that extends to the supplies. In the off condition, signal levels up to the supplies are blocked. All switches exhibit break-before-make switching action.

### FUNCTIONAL BLOCK DIAGRAM



### **PRODUCT HIGHLIGHTS**

- 1. Trench Isolation Guards Against Latch-Up. A dielectric trench separates the P and N channel transistors, thereby preventing latch-up even under severe overvoltage conditions.
- 2. Ultralow Capacitance and <1 pC Charge Injection.
- Dual-Supply Operation.
  For applications where the analog signal is bipolar, the ADG5204 can be operated from dual supplies up to ±22 V.
- Single-Supply Operation. For applications where the analog signal is unipolar, the ADG5204 can be operated from a single rail power supply up to 40 V.
- 5. 3 V Logic-Compatible Digital Inputs.  $V_{INH} = 2.0 \text{ V}, V_{INL} = 0.8 \text{ V}.$
- 6. No V<sub>L</sub> Logic Power Supply Required.

## **TABLE OF CONTENTS**

Features 1
Applications1
Functional Block Diagram 1
General Description 1
Product Highlights 1
Revision History 2
Specifications
±15 V Dual Supply
±20 V Dual Supply 4
12 V Single Supply5
36 V Single Supply 6
Continuous Current per Channel, Sx or D7

Absolute Maximum Ratings	8
ESD Caution	8
Pin Configurations and Function Descriptions	9
Truth Table	9
Typical Performance Characteristics	10
Test Circuits	14
Terminology	16
Trench Isolation	17
Applications Information	
Outline Dimensions	19
Ordering Guide	19

### **REVISION HISTORY**

5/11—Revision 0: Initial Version

## **SPECIFICATIONS**

## ±15 V DUAL SUPPLY

 $V_{\text{DD}}$  = 15 V  $\pm$  10%,  $V_{\text{SS}}$  = –15 V  $\pm$  10%, GND = 0 V, unless otherwise noted.

### Table 1.

Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			V <sub>DD</sub> to V <sub>SS</sub>	V max	
On Resistance, Ron	160			Ωtyp	$V_s = \pm 10 V$ , $I_s = -1 mA$ , see Figure 24
	200	250	280	Ωmax	$V_{DD} = +13.5 \text{ V}, \text{ V}_{SS} = -13.5 \text{ V}$
On-Resistance Match	4.5			Ωtyp	$V_{s} = \pm 10 V$ , $I_{s} = -1 mA$
Between Channels, ΔR <sub>ON</sub>					
	8	9	10	Ωmax	
On-Resistance Flatness, R <sub>FLAT(ON)</sub>	38			Ωtyp	$V_s = \pm 10 V$ , $I_s = -1 mA$
	50	65	70	Ωmax	
LEAKAGE CURRENTS					$V_{DD} = +16.5 \text{ V}, \text{ V}_{SS} = -16.5 \text{ V}$
Source Off Leakage, Is (Off)	0.01			nA typ	
		0.2	0.4		$V_{\text{S}}$ = $V_{\text{S}}$ = $\pm 10$ V, $V_{\text{D}}$ = $\mp 10$ V, see Figure 23
	0.1	0.2	0.4	nA max	
Drain Off Leakage, I <sub>D</sub> (Off)	0.01			nA typ	$V_{\text{S}}$ = $V_{\text{S}}$ = $\pm 10$ V, $V_{\text{D}}$ = $\mp 10$ V, see Figure 23
	0.1	0.4	1.2	nA max	
Channel On Leakage, I <sub>D</sub> , I <sub>S</sub> (On)	0.02			nA typ	$V_s = V_D = \pm 10 V$ , see Figure 26
	0.2	0.5	1.2	nA max	
DIGITAL INPUTS					
Input High Voltage, V <sub>INH</sub>			2.0	V min	
Input Low Voltage, VINL			0.8	V max	
Input Current, I <sub>INL</sub> or I <sub>INH</sub>	0.002			μA typ	$V_{IN} = V_{GND} \text{ or } V_{DD}$
			±0.1	μA max	
Digital Input Capacitance, C <sub>IN</sub>	3			pF typ	
DYNAMIC CHARACTERISTICS <sup>1</sup>	-			P: 0P	
Transition Time, transition	175			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
Transition Time, transition	230	285	320	ns max	$V_s = 10 V$ , see Figure 29
t <sub>on</sub> (EN)	155	205	520		$R_L = 300 \Omega, C_L = 35 \text{ pF}$
ton (LIN)	205	255	285	ns typ ns max	$V_s = 10 V$ , see Figure 31
+ (ENI)	150	255	205		$R_L = 300 \Omega$ , $C_L = 35 pF$
t <sub>off</sub> (EN)		200	215	ns typ	
Ducal Defeue Male Time Delay t	175	200	215	ns max	$V_s = 10 V$ , see Figure 31
Break-Before-Make Time Delay, $t_D$	80		20	ns typ	$R_L = 300 \Omega, C_L = 35 pF$
			30	ns min	$V_{s1} = V_{s2} = 10 V$ , see Figure 30
Charge Injection, Q <sub>INJ</sub>	-0.6			pC typ	$V_s = 0 V, R_s = 0 \Omega, C_L = 1 nF$ , see Figure 32
Off Isolation	-80			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 100 kHz$ , see Figure 25
Channel-to-Channel Crosstalk	-80			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 28
–3 dB Bandwidth	136			MHz typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , see Figure 27
Insertion Loss	-6.8			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 27
C <sub>s</sub> (Off)	3			pF typ	$V_{s} = 0 V, f = 1 MHz$
C <sub>D</sub> (Off)	26			pF typ	$V_{s} = 0 V, f = 1 MHz$
C <sub>D</sub> , C <sub>s</sub> (On)	30			pF typ	$V_{s} = 0 V, f = 1 MHz$
POWER REQUIREMENTS					$V_{DD} = +16.5 \text{ V}, V_{SS} = -16.5 \text{ V}$
I <sub>DD</sub>	45			μA typ	Digital inputs = $0 V$ or $V_{DD}$
	55		70	μA max	
I <sub>SS</sub>	0.001			μA typ	Digital inputs = $0 V \text{ or } V_{DD}$
			1	µA max	
V <sub>DD</sub> /V <sub>SS</sub>			±9/±22	V min/max	GND = 0 V

## ±20 V DUAL SUPPLY

 $V_{\text{DD}}$  = +20 V  $\pm$  10%,  $V_{\text{SS}}$  = -20 V  $\pm$  10%, GND = 0 V, unless otherwise noted.

## Table 2.

Parameter	25°C	-40°C to +85°C	-40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			V <sub>DD</sub> to V <sub>SS</sub>	V max	
On Resistance, Ron	140			Ωtyp	$V_s = \pm 15 V$ , $I_s = -1 mA$ , see Figure 24
	160	200	230	Ωmax	$V_{DD} = +18 V, V_{SS} = -18 V$
On-Resistance Match Between Channels, ΔR <sub>on</sub>	4.5			Ωtyp	$V_s = \pm 15 V$ , $I_s = -1 mA$
	8	9	10	Ωmax	
On-Resistance Flatness, R <sub>FLAT(ON)</sub>	33			Ωtyp	$V_{s} = \pm 15 V, I_{s} = -1 mA$
	45	55	60	Ωmax	2 7 9 2
LEAKAGE CURRENTS					$V_{DD} = +22 V, V_{SS} = -22 V$
Source Off Leakage, $I_s$ (Off)	0.01			nA typ	$V_s = \pm 15 \text{ V}, V_D = \mp 15 \text{ V}, \text{ see Figure 23}$
	0.1	0.2	0.4	nA max	
Drain Off Leakage, I <sub>D</sub> (Off)	0.01			nA typ	$V_s = \pm 15 V$ , $V_D = \mp 15 V$ , see Figure 23
	0.1	0.4	1.2	nA max	
Channel On Leakage, I <sub>D</sub> , I <sub>S</sub> (On)	0.02			nA typ	$V_s = V_D = \pm 15 V$ , see Figure 26
c	0.2	0.5	1.2	nA max	······································
DIGITAL INPUTS	0.2	0.5	1.2	The contract	
Input High Voltage, V <sub>INH</sub>			2.0	V min	
Input Low Voltage, VINI			0.8	V max	
Input Current, IINL or IINH	0.002		0.0	μA typ	$V_{IN} = V_{GND} \text{ or } V_{DD}$
	0.002		±0.1	μA max	
Digital Input Capacitance, C <sub>IN</sub>	3		±0.1	pF typ	
	5				
	160			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
Transition Time, transmon	215	260	290	ns max	$V_s = 10 V_s$ see Figure 29
t <sub>on</sub> (EN)	150	200	250	ns typ	$R_L = 300 \Omega, C_L = 35 \text{ pF}$
	185	225	255	ns max	$V_s = 10 V_s$ see Figure 31
toff (EN)	150	225	233	ns typ	$R_L = 300 \Omega, C_L = 35 pF$
	175	195	210	ns max	$V_s = 10 V_s$ see Figure 31
Break-Before-Make Time Delay, t₀	75	155	210	ns typ	$R_L = 300 \Omega, C_L = 35 pF$
break before make time belay, to	/5		30	ns min	$V_{s1} = V_{s2} = 10 V$ , see Figure 30
Charge Injection, Q <sub>INJ</sub>	-0.6		50	pC typ	$V_s = 0 V$ , $R_s = 0 \Omega$ , $C_L = 1 nF$ , see Figure 32
Off Isolation	-80			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 100 kHz$ , see Figure 25
Channel-to-Channel Crosstalk	-80			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 28
-3 dB Bandwidth	150			MHz typ	$R_L = 50 \Omega_2$ , $C_L = 5 pF$ , see Figure 27
Insertion Loss	-6			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 27 $R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 27
C <sub>s</sub> (Off)	3			pF typ	$V_s = 0 V, f = 1 MHz$
C <sub>D</sub> (Off)	26			pF typ	$V_{s} = 0 V, f = 1 MHz$ $V_{s} = 0 V, f = 1 MHz$
$C_D$ , $C_s$ (On)	30			pF typ	$V_{s} = 0 V, f = 1 MHz$ $V_{s} = 0 V, f = 1 MHz$
POWER REQUIREMENTS	50			pi typ	$V_{s} = 0.0, 1 = 1.0002$ $V_{DD} = +22 V, V_{SS} = -22 V$
	50			uA two	
l <sub>DD</sub>	50 70		110	μA typ	Digital inputs = $0 V \text{ or } V_{DD}$
				μA max	
lss	0.001		1	μA typ	Digital inputs = $0 V \text{ or } V_{DD}$
V <sub>DD</sub> /V <sub>SS</sub>			1	µA max	GND = 0 V
V DD/ V SS			±9/±22	V min/max	

## **12 V SINGLE SUPPLY**

 $V_{\text{DD}}$  = 12 V  $\pm$  10%,  $V_{\text{SS}}$  = 0 V, GND = 0 V, unless otherwise noted.

#### Table 3.

Parameter	25°C	–40°C to +85°C	-40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V <sub>DD</sub>	V max	
On Resistance, R <sub>on</sub>	340			Ωtyp	$V_s = 0 V$ to 10 V, $I_s = -1 mA$ , see Figure 24
	500	610	700	Ωmax	$V_{DD} = 10.8 \text{ V}, V_{SS} = 0 \text{ V}$
On-Resistance Match Between Channels, ΔR <sub>oN</sub>	5			Ωtyp	$V_{s}=0\ V\ to\ 10\ V,\ I_{s}=-1\ mA$
	20	21	22	Ωmax	
On-Resistance Flatness, R <sub>FLAT(ON)</sub>	145			Ωtyp	$V_s = 0 V$ to 10 V, $I_s = -1 mA$
	280	335	370	Ωmax	
LEAKAGE CURRENTS					$V_{DD} = 13.2 \text{ V}, V_{SS} = 0 \text{ V}$
Source Off Leakage, Is (Off)	0.01			nA typ	$V_s = 1 \text{ V}/10 \text{ V}, V_D = 10 \text{ V}/1 \text{ V}, \text{ see Figure 23}$
-	0.1	0.2	0.4	nA max	
Drain Off Leakage, I₀ (Off)	0.01			nA typ	$V_s = 1 V/10 V$ , $V_D = 10 V/1 V$ , see Figure 23
-	0.1	0.4	1.2	nA max	
Channel On Leakage, I <sub>D</sub> , I <sub>s</sub> (On)	0.02			nA typ	$V_{s} = V_{D} = 1 \text{ V}/10 \text{ V}$ , see Figure 26
	0.2	0.5	1.2	nA max	
DIGITAL INPUTS					
Input High Voltage, V <sub>INH</sub>			2.0	V min	
Input Low Voltage, V <sub>INL</sub>			0.8	V max	
Input Current, I <sub>INL</sub> or I <sub>INH</sub>	0.002			µA typ	$V_{IN} = V_{GND} \text{ or } V_{DD}$
			±0.1	µA max	
Digital Input Capacitance, C <sub>№</sub>	3			pF typ	
DYNAMIC CHARACTERISTICS <sup>1</sup>				1 /1	
Transition Time, t <sub>TRANSITION</sub>	240			ns typ	$R_{L} = 300 \Omega, C_{L} = 35 pF$
,	350	445	515	ns max	$V_s = 8 V$ , see Figure 29
t <sub>on</sub> (EN)	250			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
	335	420	485	ns max	$V_s = 8 V$ , see Figure 31
t <sub>off</sub> (EN)	160			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
	195	220	240	ns max	$V_s = 8 V$ , see Figure 31
Break-Before-Make Time Delay, t <sub>D</sub>	140			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,			60	ns min	$V_{s1} = V_{s2} = 8 V$ , see Figure 30
Charge Injection, Q <sub>INJ</sub>	-1.2			pC typ	$V_s = 6 V$ , $R_s = 0 \Omega$ , $C_L = 1 nF$ , see Figure 32
Off Isolation	-80			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 25
Channel-to-Channel Crosstalk	-80			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 28
-3 dB Bandwidth	106			MHz typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , see Figure 27
Insertion Loss	-11			dB typ	$R_L = 50 \Omega$ , $C_L = 5 \text{ pF}$ , $f = 1 \text{ MHz}$ , see Figure 27
Cs (Off)	3.5			pF typ	$V_s = 6 V, f = 1 MHz$
$C_{D}$ (Off)	29			pF typ	$V_{s} = 6 V, f = 1 MHz$
$C_D, C_S$ (On)	33			pF typ	$V_{s} = 6 V, f = 1 MHz$
POWER REQUIREMENTS	55			רטייק	$V_{DD} = 13.2 V$
	40			μA typ	Digital inputs = $0 \text{ V} \text{ or } V_{DD}$
עטו			65	μΑ typ μΑ max	
Van					GND = 0 V V = 0 V
V <sub>DD</sub>			9/40	V min/max	$GND=0\;V,V_{SS}=0\;V$

## **36 V SINGLE SUPPLY**

 $V_{\text{DD}}$  = 36 V  $\pm$  10%,  $V_{\text{SS}}$  = 0 V, GND = 0 V, unless otherwise noted.

#### Table 4.

Parameter	25°C	–40°C to +85°C	-40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			$0 V to V_{DD}$	V max	
On Resistance, R <sub>on</sub>	150			Ωtyp	$V_s = 0 V$ to 30 V, $I_s = -1 mA$ , see Figure 24
	170	215	245	Ωmax	$V_{DD} = 32.4 \text{ V}, \text{ V}_{SS} = 0 \text{ V}$
On-Resistance Match Between Channels, ΔR <sub>ON</sub>	4.5			Ωtyp	$V_s = 0$ V to 30 V, $I_s = -1$ mA
	8	9	10	Ωmax	
On-Resistance Flatness, R <sub>FLAT(ON)</sub>	35			Ωtyp	$V_s = 0 V$ to 30 V, $I_s = -1 mA$
	50	60	65	Ωmax	
LEAKAGE CURRENTS					$V_{DD} = 39.6 \text{ V}, \text{ V}_{SS} = 0 \text{ V}$
Source Off Leakage, Is (Off)	0.01			nA typ	$V_{s} = 1 \text{ V}/30 \text{ V}, V_{D} = 30 \text{ V}/1 \text{ V}, \text{ see Figure 23}$
-	0.1	0.2	0.4	nA max	_
Drain Off Leakage, I <sub>D</sub> (Off)	0.01			nA typ	$V_{s} = 1 \text{ V}/30 \text{ V}, V_{D} = 30 \text{ V}/1 \text{ V}, \text{ see Figure 23}$
-	0.1	0.4	1.2	nA max	
Channel On Leakage, I <sub>D</sub> , I <sub>S</sub> (On)	0.02			nA typ	$V_{s} = V_{D} = 1 \text{ V}/30 \text{ V}$ , see Figure 26
	0.2	0.5	1.2	nA max	
DIGITAL INPUTS					
Input High Voltage, V <sub>INH</sub>			2.0	V min	
Input Low Voltage, V <sub>INL</sub>			0.8	V max	
Input Current, Inc or Inh	0.002			μA typ	$V_{IN} = V_{GND} \text{ or } V_{DD}$
• •			±0.1	μA max	
Digital Input Capacitance, C <sub>IN</sub>	3			pF typ	
DYNAMIC CHARACTERISTICS <sup>1</sup>					
Transition Time, t <sub>TRANSITION</sub>	180			ns typ	$R_{L} = 300 \Omega, C_{L} = 35 pF$
	250	275	305	ns max	$V_s = 18 V$ , see Figure 29
t <sub>on</sub> (EN)	170			ns typ	$R_{\rm I} = 300 \Omega, C_{\rm I} = 35 \mathrm{pF}$
	220	251	285	ns max	$V_s = 18 V$ , see Figure 31
t <sub>off</sub> (EN)	170			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
	210	215	220	ns max	$V_s = 18 V$ , see Figure 31
Break-Before-Make Time Delay, t <sub>D</sub>	80			ns typ	$R_L = 300 \Omega, C_L = 35 pF$
,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,			30	ns min	$V_{s1} = V_{s2} = 18 V$ , see Figure 30
Charge Injection, Q <sub>INJ</sub>	-0.6			pC typ	$V_s = 18 V$ , $R_s = 0 \Omega$ , $C_L = 1 nF$ , see Figure 32
Off Isolation	-80			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 25
Channel-to-Channel Crosstalk	-80			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 28
-3 dB Bandwidth	136			MHz typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , see Figure 27
Insertion Loss	-6.7			dB typ	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$ , see Figure 27
Cs (Off)	3			pF typ	$V_s = 18 V, f = 1 MHz$
C <sub>D</sub> (Off)	26			pF typ	$V_{s} = 18 V, f = 1 MHz$
C <sub>D</sub> , C <sub>s</sub> (On)	30			pF typ	$V_s = 18 V, f = 1 MHz$
POWER REQUIREMENTS				F7 9P	$V_{DD} = 39.6 V$
	85			μA typ	Digital inputs = $0 \text{ V} \text{ or } V_{DD}$
	100		130	μA max	
V <sub>DD</sub>	100		9/40	V min/max	$GND = 0 V, V_{ss} = 0 V$

## CONTINUOUS CURRENT PER CHANNEL, Sx OR D

Table 5.

Parameter	25°C	85°C	125°C	Unit
CONTINUOUS CURRENT, Sx OR D PINS				
$V_{DD} = +15 V, V_{SS} = -15 V$				
TSSOP ( $\theta_{JA} = 112.6^{\circ}C/W$ )	24.5	7.5	2.8	mA max
LFCSP ( $\theta_{JA} = 30.4^{\circ}C/W$ )	35.7	7.7	2.8	mA max
$V_{DD} = +20 V, V_{SS} = -20 V$				
TSSOP ( $\theta_{JA} = 112.6^{\circ}C/W$ )	26	7.5	2.8	mA max
LFCSP ( $\theta_{JA} = 30.4^{\circ}C/W$ )	37	7.7	2.8	mA max
$V_{DD} = 12 V, V_{SS} = 0 V$				
TSSOP ( $\theta_{JA} = 112.6^{\circ}C/W$ )	18	7	2.8	mA max
LFCSP ( $\theta_{JA} = 30.4^{\circ}C/W$ )	28	7.7	2.8	mA max
$V_{DD} = 36 V, V_{SS} = 0 V$				
TSSOP ( $\theta_{JA} = 112.6^{\circ}C/W$ )	30	7.7	2.8	mA max
LFCSP ( $\theta_{JA} = 30.4^{\circ}C/W$ )	41	7.7	2.8	mA max

## **ABSOLUTE MAXIMUM RATINGS**

 $T_A = 25^{\circ}C$ , unless otherwise noted.

#### Table 6.

1 4010 01	
Parameter	Rating
V <sub>DD</sub> to V <sub>SS</sub>	48 V
V <sub>DD</sub> to GND	–0.3 V to +48 V
Vss to GND	+0.3 V to -48 V
Analog Inputs <sup>1</sup>	V <sub>ss</sub> – 0.3 V to V <sub>DD</sub> + 0.3 V or 30 mA, whichever occurs first
Digital Inputs <sup>1</sup>	V <sub>ss</sub> – 0.3 V to V <sub>DD</sub> + 0.3 V or 30 mA, whichever occurs first
Peak Current, Sx or D Pins	81 mA (pulsed at 1 ms, 10% duty cycle maximum)
Continuous Current, Sx or D <sup>2</sup>	Data + 15%
Operating Temperature Range	–40°C to +125°C
Storage Temperature Range	–65°C to +150°C
Junction Temperature	150°C
Thermal Impedance, θ <sub>JA</sub>	
16-Lead TSSOP, θյ₄ Thermal Impedance (4-Layer Board)	112.6°C/W
16-Lead LFCSP, θ <sub>JA</sub> Thermal Impedance (4-Layer Board)	30.4°C/W
Reflow Soldering Peak Temperature, Pb Free	260(+0/-5)°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Only one absolute maximum rating can be applied at any one time.

### **ESD CAUTION**

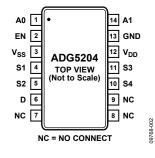


**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

<sup>1</sup> Overvoltages at the Sx and D pins are clamped by internal diodes. Limit current to the maximum ratings given.

<sup>2</sup> See Table 5.

## **PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS**



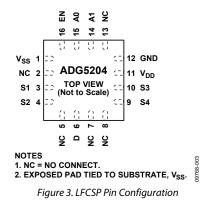


Figure 2. TSSOP Pin Configuration

Table 7. Pin Function Descriptions

P	'in No.		
TSSOP	LFCSP	Mnemonic	Description
1	15	A0	Logic Control Input.
2	16	EN	Active High Digital Input. When this pin is low, the device is disabled and all switches are off. When this pin is high, the Ax logic inputs determine the on switches.
3	1	Vss	Most Negative Power Supply Potential.
4	3	S1	Source Terminal. Can be an input or an output.
5	4	S2	Source Terminal. Can be an input or an output.
6	6	D	Drain Terminal. Can be an input or an output.
7 to 9	2, 5, 7, 8, 13	NC	No Connect. These pins are open.
10	9	S4	Source Terminal. Can be an input or an output.
11	10	S3	Source Terminal. Can be an input or an output.
12	11	V <sub>DD</sub>	Most Positive Power Supply Potential.
13	12	GND	Ground (0 V) Reference.
14	14	A1	Logic Control Input.
N/A <sup>1</sup>	EP	Exposed Pad	Exposed Pad. The exposed pad is connected internally. For increased reliability of the solder joints and maximum thermal capability, it is recommended that the pad be soldered to the substrate, V <sub>SS</sub> .

<sup>1</sup> N/A means not applicable.

### **TRUTH TABLE**

Table 8.

EN	A1	A0	S1	S2	S3	S4
0	X <sup>1</sup>	X <sup>1</sup>	Off	Off	Off	Off
1	0	0	On	Off	Off	Off
1	0	1	Off	On	Off	Off
1	1	0	Off	Off	On	Off
1	1	1	Off	Off	Off	On

<sup>1</sup> X is don't care.

## **TYPICAL PERFORMANCE CHARACTERISTICS**

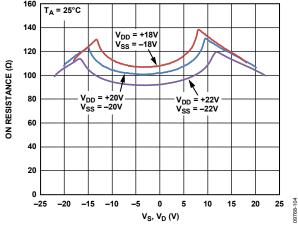
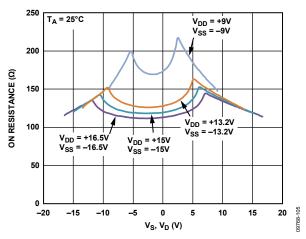
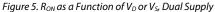


Figure 4. R<sub>ON</sub> as a Function of V<sub>D</sub> or V<sub>S</sub>, Dual Supply





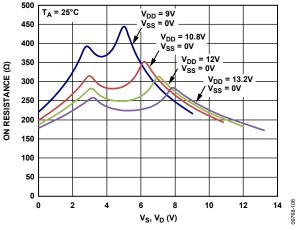


Figure 6. R<sub>ON</sub> as a Function of V<sub>D</sub> or V<sub>S</sub>, Single Supply

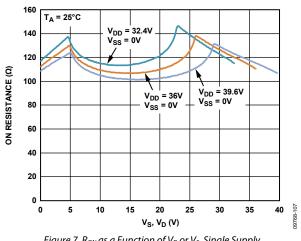


Figure 7. R<sub>ON</sub> as a Function of V<sub>D</sub> or V<sub>S</sub>, Single Supply

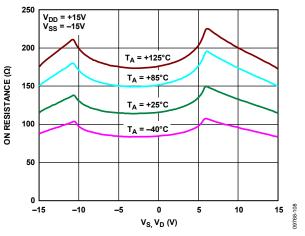


Figure 8.  $R_{ON}$  as a Function of  $V_D$  or  $V_S$ , for Different Temperatures, ±15 V Dual Supply

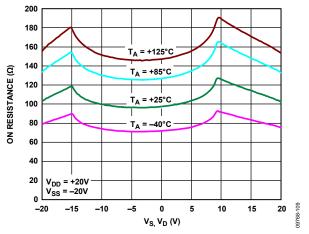


Figure 9. R<sub>ON</sub> as a Function of V<sub>D</sub> or V<sub>s</sub>, for Different Temperatures, ±20 V Dual Supply

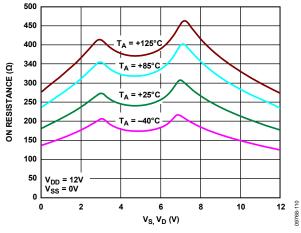


Figure 10.  $R_{ON}$  as a Function of  $V_D$  or  $V_S$  for Different Temperatures, 12 V Single Supply

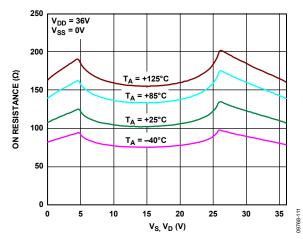


Figure 11.  $R_{ON}$  as a Function of  $V_D$  or  $V_S$  for Different Temperatures, 36 V Single Supply

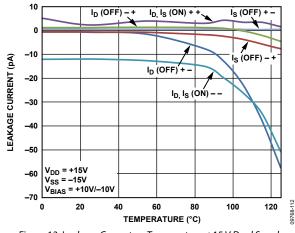


Figure 12. Leakage Current vs. Temperature, ±15 V Dual Supply

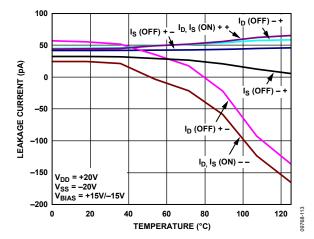
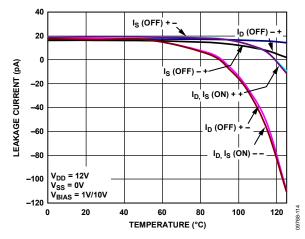
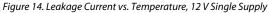


Figure 13. Leakage Current vs. Temperature, ±20 V Dual Supply





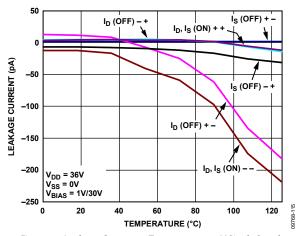


Figure 15. Leakage Current vs. Temperature, 36 V Single Supply

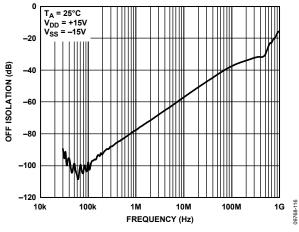
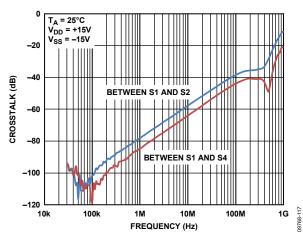
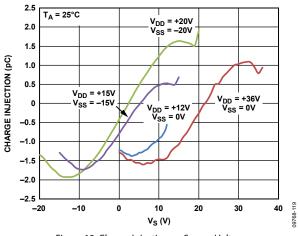


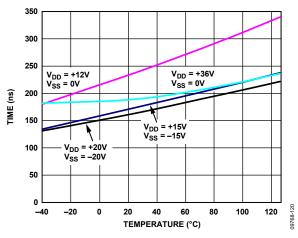
Figure 16. Off Isolation vs. Frequency,  $\pm 15$  V Dual Supply

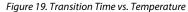


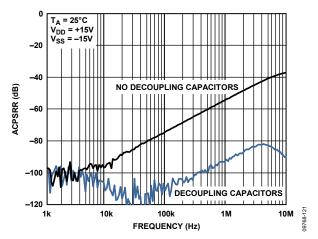


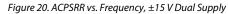












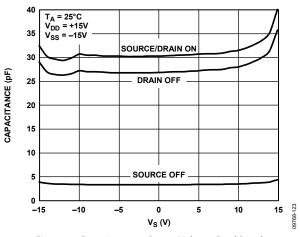


Figure 21. Capacitance vs. Source Voltage, Dual Supply

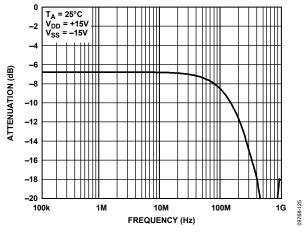
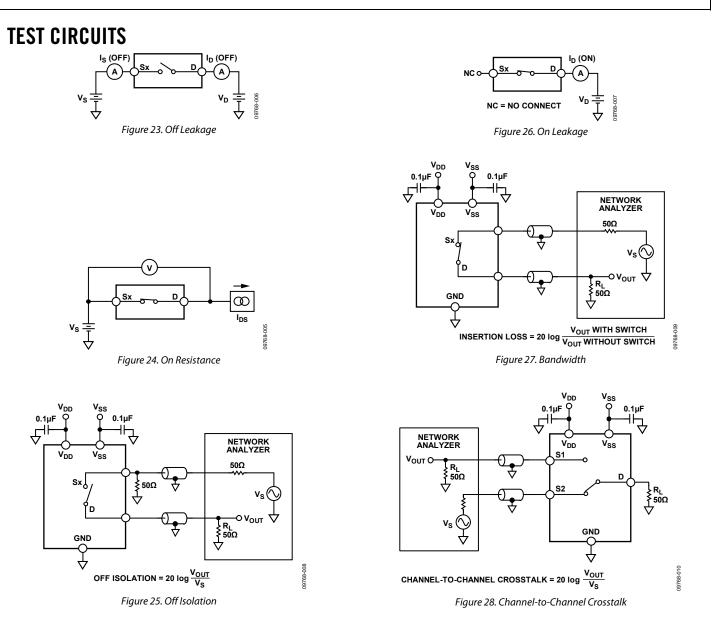
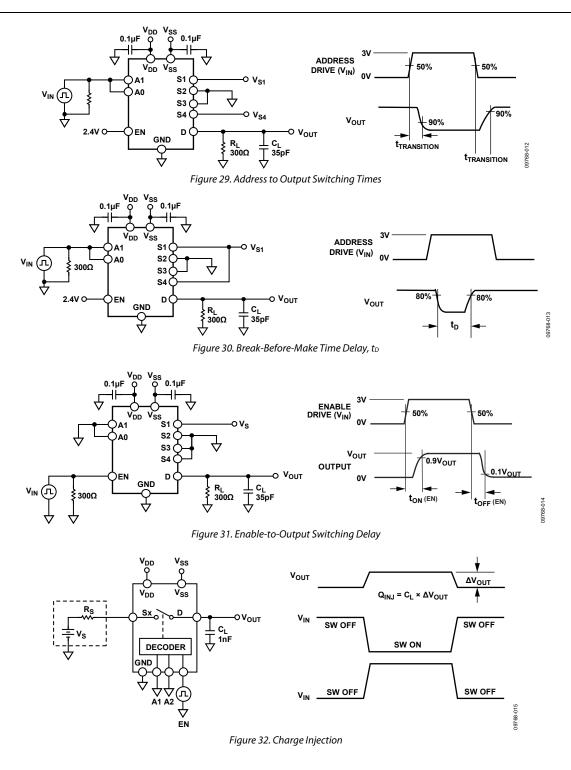


Figure 22. Bandwidth





## TERMINOLOGY

#### Idd

The positive supply current.

### Iss

The negative supply current.

## $\mathbf{V}_{\mathrm{D}}, \mathbf{V}_{\mathrm{S}}$

The analog voltage on Terminal D and Terminal S.

### Ron

The ohmic resistance between Terminal D and Terminal S.

### R<sub>FLAT(ON)</sub>

Flatness that is defined as the difference between the maximum and minimum value of on resistance measured over the specified analog signal range.

### Is (Off)

The source leakage current with the switch off.

 $\mathbf{I}_{\mathrm{D}}$  (Off) The drain leakage current with the switch off.

I<sub>D</sub>, I<sub>S</sub> (On) The channel leakage current with the switch on.

### VINL

The maximum input voltage for Logic 0.

 $V_{\mbox{\scriptsize INH}}$  The minimum input voltage for Logic 1.

 $I_{\rm INL},\,I_{\rm INH}$  The input current of the digital input.

## Cs (Off)

The off switch source capacitance, which is measured with reference to ground.

## C<sub>D</sub> (Off)

The off switch drain capacitance, which is measured with reference to ground.

### $C_D$ (On), $C_S$ (On)

The on switch capacitance, which is measured with reference to ground.

### Cin

The digital input capacitance.

### **t**TRANSITION

The delay time between the 50% and 90% points of the digital input and switch-on condition when switching from one address state to another.

#### $t_{\rm ON}$ (EN)

The delay between applying the digital control input and the output switching on. See Figure 31.

### toff (EN)

The delay between applying the digital control input and the output switching off. See Figure 31.

### **Charge Injection**

A measure of the glitch impulse transferred from the digital input to the analog output during switching.

### **Off Isolation**

A measure of unwanted signal coupling through an off switch.

### Crosstalk

A measure of unwanted signal that is coupled through from one channel to another as a result of parasitic capacitance.

### Bandwidth

The frequency at which the output is attenuated by 3 dB.

## On Response

The frequency response of the on switch.

## Insertion Loss

The loss due to the on resistance of the switch.

#### ACPSRR (AC Power Supply Rejection Ratio)

The ratio of the amplitude of signal on the output to the amplitude of the modulation. This is a measure of the ability of the device to avoid coupling noise and spurious signals that appear on the supply voltage pins to the output of the switch. The dc voltage on the device is modulated by a sine wave of 0.62 V p-p.

## **TRENCH ISOLATION**

In the ADG5204, an insulating oxide layer (trench) is placed between the NMOS and the PMOS transistors of each CMOS switch. Parasitic junctions, which occur between the transistors in junction isolated switches, are eliminated, and the result is a completely latch-up proof switch.

In junction isolation, the N and P wells of the PMOS and NMOS transistors form a diode that is reverse-biased under normal operation. However, during overvoltage conditions, this diode can become forward-biased. A silicon controlled rectifier (SCR) type circuit is formed by the two transistors causing a significant amplification of the current that, in turn, leads to latch-up. By using trench isolation, this diode is removed, and the result is a latch-up proof switch.

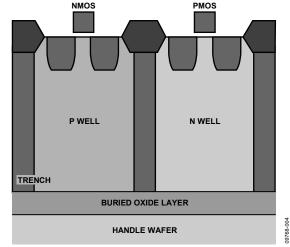
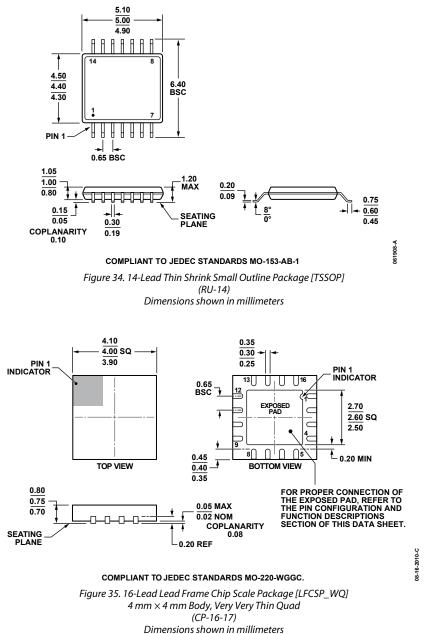


Figure 33. Trench Isolation

## **APPLICATIONS INFORMATION**

The ADG52xx family of switches and multiplexers provide a robust solution for instrumentation, industrial, automotive, aerospace, and other harsh environments that are prone to latch-up, which is an undesirable high current state that can lead to device failure and persists until the power supply is turned off. The ADG5204 high voltage multiplexer allows single-supply operation from 9 V to 40 V and dual-supply operation from  $\pm 9$  V to  $\pm 22$  V.

## **OUTLINE DIMENSIONS**



#### **ORDERING GUIDE**

Model <sup>1</sup>	Temperature Range	Package Description	Package Option
ADG5204BRUZ	-40°C to +125°C	14-Lead Thin Shrink Small Outline Package [TSSOP]	RU-14
ADG5204BRUZ-RL7	-40°C to +125°C	14-Lead Thin Shrink Small Outline Package [TSSOP]	RU-14
ADG5204BCPZ-RL7	-40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP_WQ]	CP-16-17

<sup>1</sup> Z = RoHS Compliant Part.

## NOTES

©2011 Analog Devices, Inc. All rights reserved. Trademarks and registered trademarks are the property of their respective owners. D09768-0-5/11(0)



www.analog.com

Rev. 0 | Page 20 of 20